

40V, 190A, 2.1mΩ N-channel Power Trench MOSFET

JMTC025N04D

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant

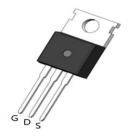
Applications

- Load Switch
- PWM Application
- Power Management

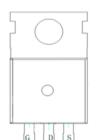
Product Summary

Parameters	Value	Unit
V_{DSS}	40	V
$V_{GS(th)_Typ}$	2.7	V
$I_D(@V_{GS}=10V)$	190	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	2.1	mΩ

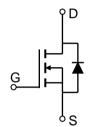








Pin Assignment



Schematic

Ordering Information

Device	Marking	MSL	Form	Package	Tube(pcs)	Per Carton (pcs)
JMTC025N04D	JMTC025N04D	N/A	Tape&Reel	TO-220-3L	50	5000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		40	V
V_{GS}	Gate-to-Source Voltage		±25	V
I_	Continuous Drain Current	$T_C = 25^{\circ}C$	190	Α
I _D		$T_C = 100$ °C	134	
I_{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energy (2)		711	mJ
P_{D}		$T_C = 25^{\circ}C$	309	W
' D		$T_C = 100$ °C	123]
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	50	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	Thermal Resistance, Junction to Case 0.4	



Electrical Characteristics (T_J = 25°C unless otherwise specified)

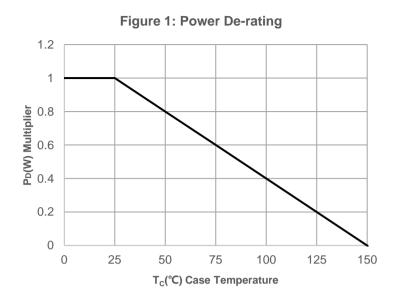
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit		
Off Characteristics								
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40V, V_{GS} = 0V$	-	-	1.0	μА		
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA		
On Cha	racteristics							
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.9	2.7	4.0	V		
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 30A$	-	2.1	2.6	mΩ		
Dynami	c Characteristics							
R_g	Gate Resistance	f = 1MHz	-	1.0	-	Ω		
C _{iss}	Input Capacitance	V 0V V 00V	-	9516	-	pF		
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	-	962	-	pF		
C _{rss}	Reverse Transfer Capacitance	1 - 11411 12	-	570	-	pF		
Q_g	Total Gate Charge	V 0. 10V	-	147	-	nC		
Q_gs	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_{D} = 30A$	-	50	-	nC		
Q_gd	Gate Drain("Miller") Charge	V _{DS} = 20 V, I _D = 00/V	-	31	-	nC		
Cwitchi	ng Characteristics							
	Turn-On DelayTime			26		ns		
t _{d(on)}	Turn-On Rise Time			30				
	Turn-Off DelayTime	$V_{GS} = 10V, V_{DD} = 20V$ $I_{D} = 30A, R_{GEN} = 2.7\Omega$	<u> </u>	59	-	ns		
t _{d(off)}	Turn-Off Fall Time			19	-	ns ns		
-1	iode Characteristics		-	19		115		
I _S	Maximum Continuous Body Diode Forward C	-	-	190	А			
I _{SM}	Maximum Pulsed Body Diode Forward Current		-	-	760	А		
V _{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-		1.2	V		
trr	Body Diode Reverse Recovery Time		-	33	-	ns		
Qrr	Body Diode Reverse Recovery Charge	$I_F = 30A$, di/dt = 100A/us	-	29	-	nC		

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- 2. E_{AS} condition: Starting T_J =25C, V_{DD} =20V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =53.34A, V_{DD} =0V during time in avalanche.
- 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.
- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 0.5%.



Typical Performance Characteristics



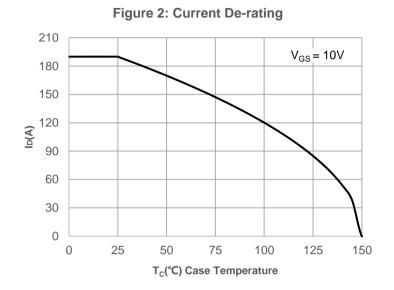
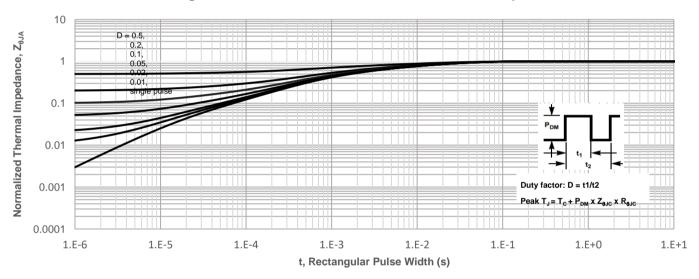
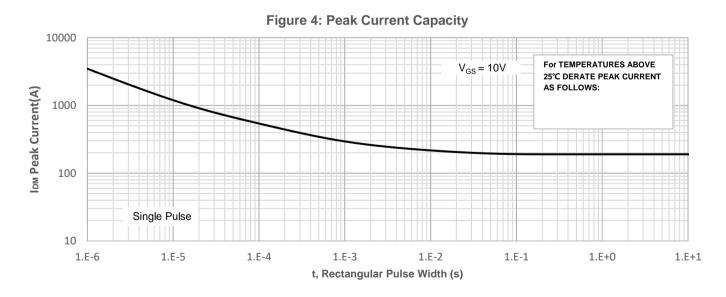


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

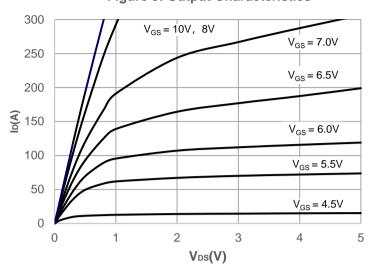


Figure 6: Typical Transfer Characteristics

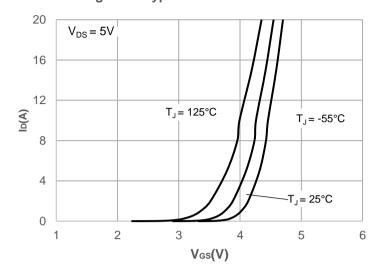


Figure 7: On-resistance vs. Drain Current

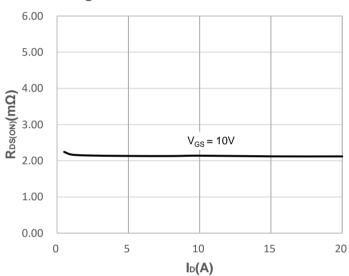


Figure 8: Body Diode Characteristics

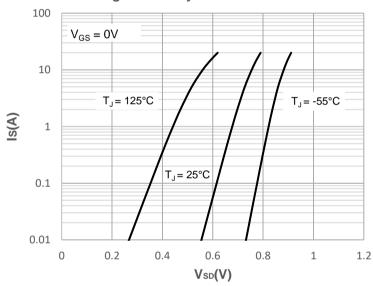


Figure 9: Gate Charge Characteristics

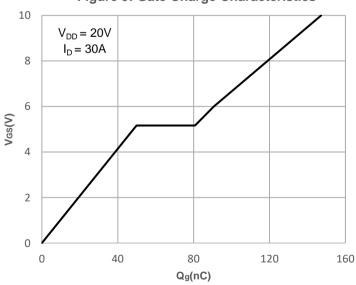
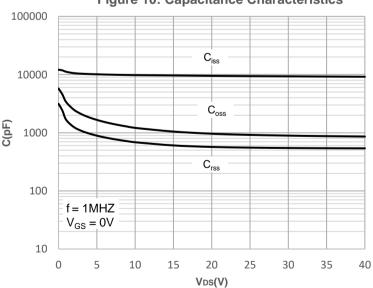


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

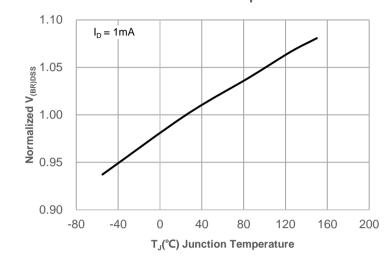


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

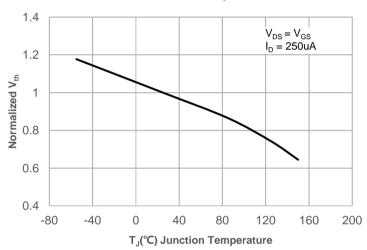


Figure 15: Maximum Safe Operating Area

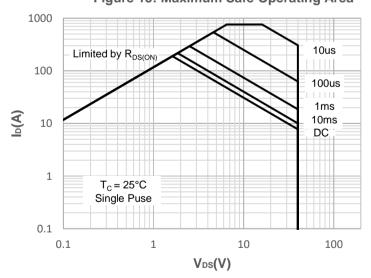
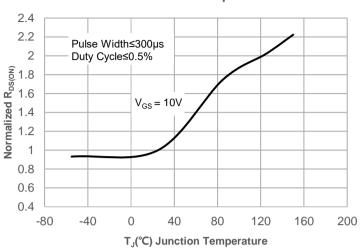
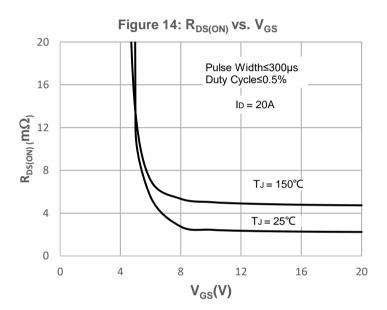


Figure 12: Normalized on Resistance vs.

Junction Temperature







Test Circuit

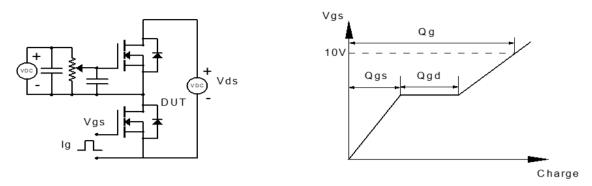


Figure 1: Gate Charge Test Circuit & Waveform

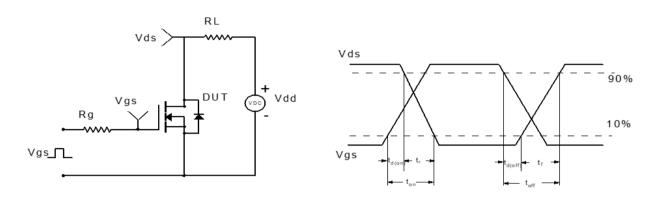


Figure 2: Resistive Switching Test Circuit & Waveform

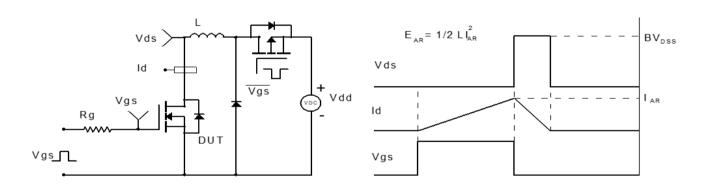


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

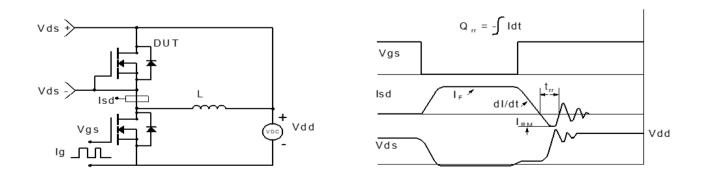
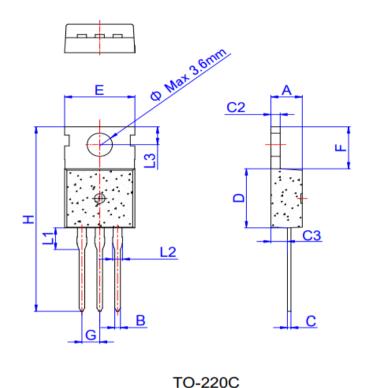


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(TO-220-3L)



	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	4.40		4.60	0.173		0.181	
В	0.70		0.90	0.028		0.035	
С	0.45		0.60	0.018		0.024	
C2	1.23		1.32	0.048		0.052	
C3	2.20		2.60	0.087		0.102	
D	8.90		9.90	0.350		0.390	
E	9.90		10.3	0.390		0.406	
F	6.30		6.90	0.248		0.272	
G		2.54			0.1		
Н	28.0		29.8	1.102		1.173	
L1		3.39			0.133		
L2	1.14		1.70	0.045		0.067	
L3	2.65		2.95	0.104		0.116	
Ф		3.6			0.142		

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